S	earch	Notes	

	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/767,373	TAKAYA ET AL.
	Examiner	Art Unit
_	TUYEN T. NGUYEN	2832

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Class	Subclass	Date	Examiner
336	65, 83, 200, 232	12/27/2005	TTN
257	531	12/27/2005	TTN
aplated		4/11/00	TTN
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INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
Same a	s above	4/4/06	TTN
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